

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Dmitry SHUR, et al  
Assignee: APPLIED MATERIALS, ISRAEL, LTD.  
Title: SYSTEM AND METHOD FOR MEASURING OVERLAY ERRORS  
Serial No.: 10/691,746 Confirmation Number: 1979  
Filed: 10/22/2003 Group Art Unit: 2881  
Attorney Docket No.: 008640 PDC/NPD Examiner: Johnston, Phillip A.  
Date: April 20, 2007

RESPONSE TO NOTICE OF NON-COMPLIANT AMENDMENT

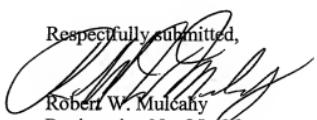
Mail Stop Amendment  
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Sir:

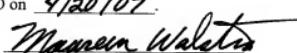
This paper is responsive to the Notice Of Non-Compliant Amendment dated 11/02/2006 having an original period of response due 12/02/2006. Further examination and reconsideration are respectfully requested.

Enclosed is a list of the Current Status of the 18 claims in the application, as required by the Examiner in the Notice of Non-Compliant Amendment. Claims 1-18 are the originally filed claims.

Respectfully submitted,

  
Robert W. Mulcahy  
Registration No. 25,436

I hereby certify that this correspondence is being e-filed at the USPTO on 4/20/07.

Signature:   
Maureen Walstra